

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10617565	NIE ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Anthony Weier	1794

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
updated	previous search	3/17/08	AW

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>